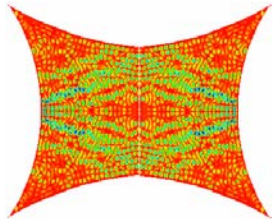


Prediction and Measurement of Induced Voltages and Currents in Complicated Metallic Enclosures



Steven M. Anlage, Sameer Hemmady,
Xing Zheng, James Hart, Chris Bertrand,
Tom Antonsen, Ed Ott



DEPARTMENT OF
PHYSICS
UNIVERSITY OF MARYLAND



Statistical Methods Meeting
13 July, 2006

Research funded by the AFOSR-MURI and DURIP programs

Goal



To develop a quantitative statistical understanding of induced voltage and current distributions in circuits inside complicated enclosures, based upon minimal information about the system

Target system information required:

Volume

Loss ($1/Q$)

Frequency / Waveform of attack

Radiation impedance of the relevant ports

Random Coupling Model (RCM) Talks, Friday 14 July, Pecos (Free and open to all!)

8:00 AM Vic Granatstein, MURI Overview

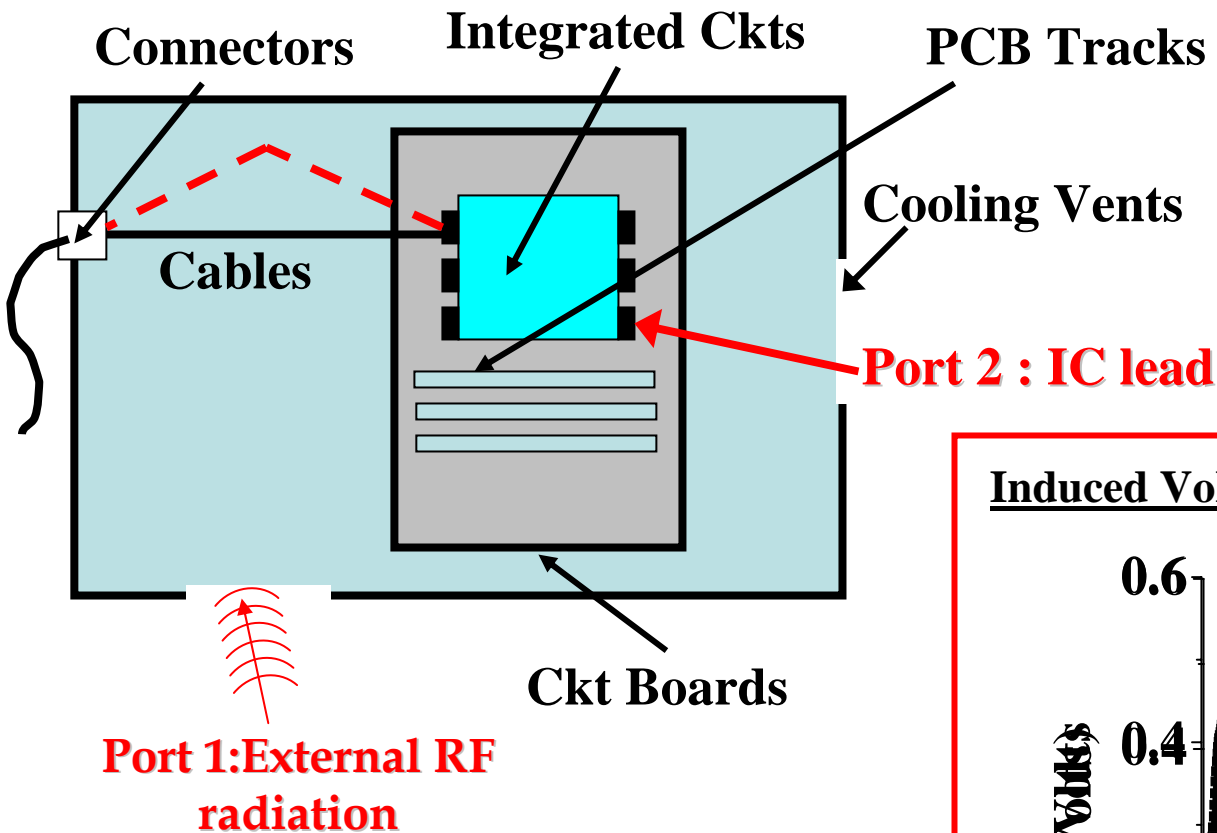
8:20 AM Ed Ott, RCM Theory

8:50 AM Sameer Hemmady, RCM in Practice

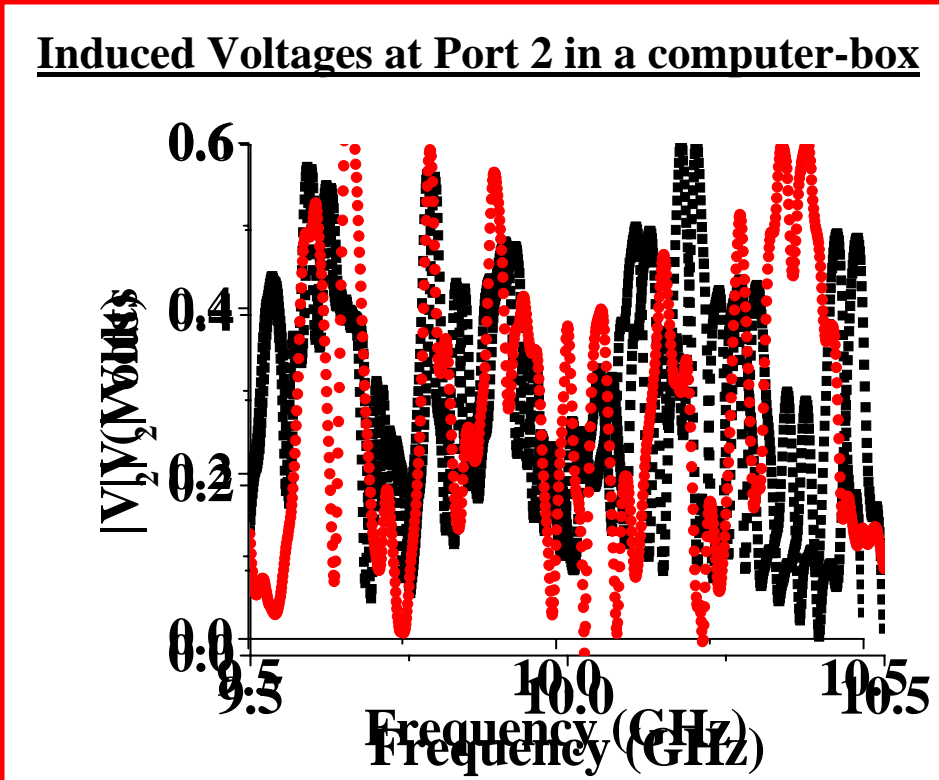
9:15 AM Steven Anlage, GHz-Frequency Circuit Chaos

9:40 AM John Rodgers, Nonlinear HPM Effects

Motivation for the Random Coupling Model

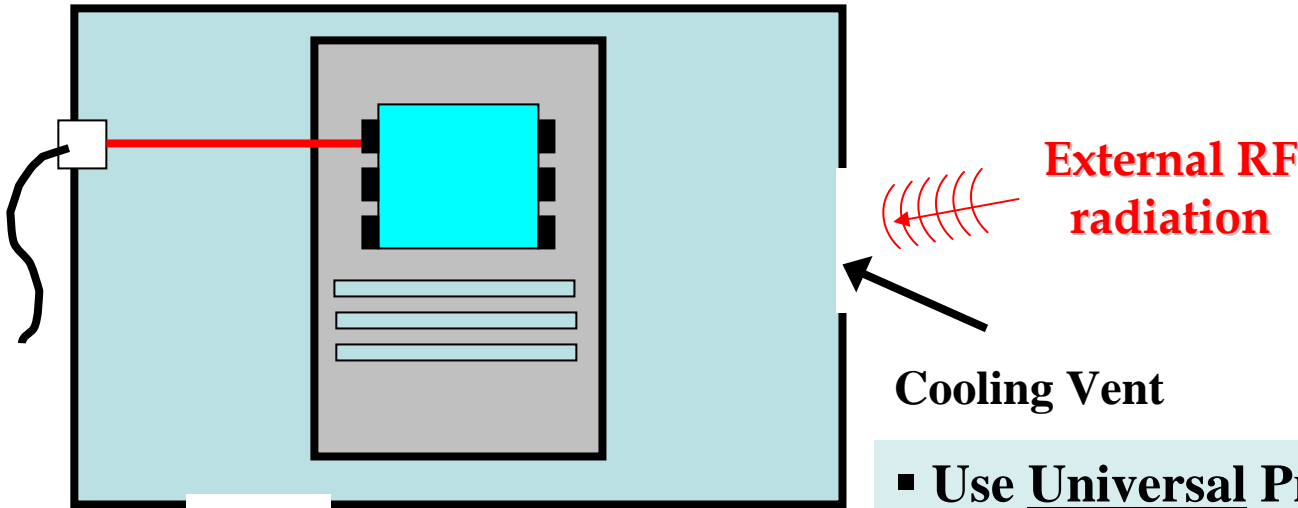


AMEREM Plenary
D. R. Wilton (312.4)
Made the case for statistical
description from computation



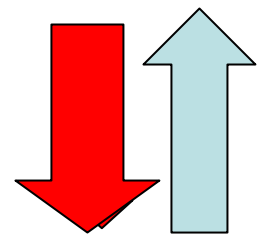
- Extreme sensitivity to system details makes numerical EM solutions based on Maxwell's equations impractical.
- Use Statistical Description !!

Our outlook on this problem:- Formulating the Random Coupling Model



Treat the computer-box as a wave-chaotic system

▪ Use Universal Properties of Wave Chaotic Systems to predict induced voltage distributions at specific locations inside the enclosure.



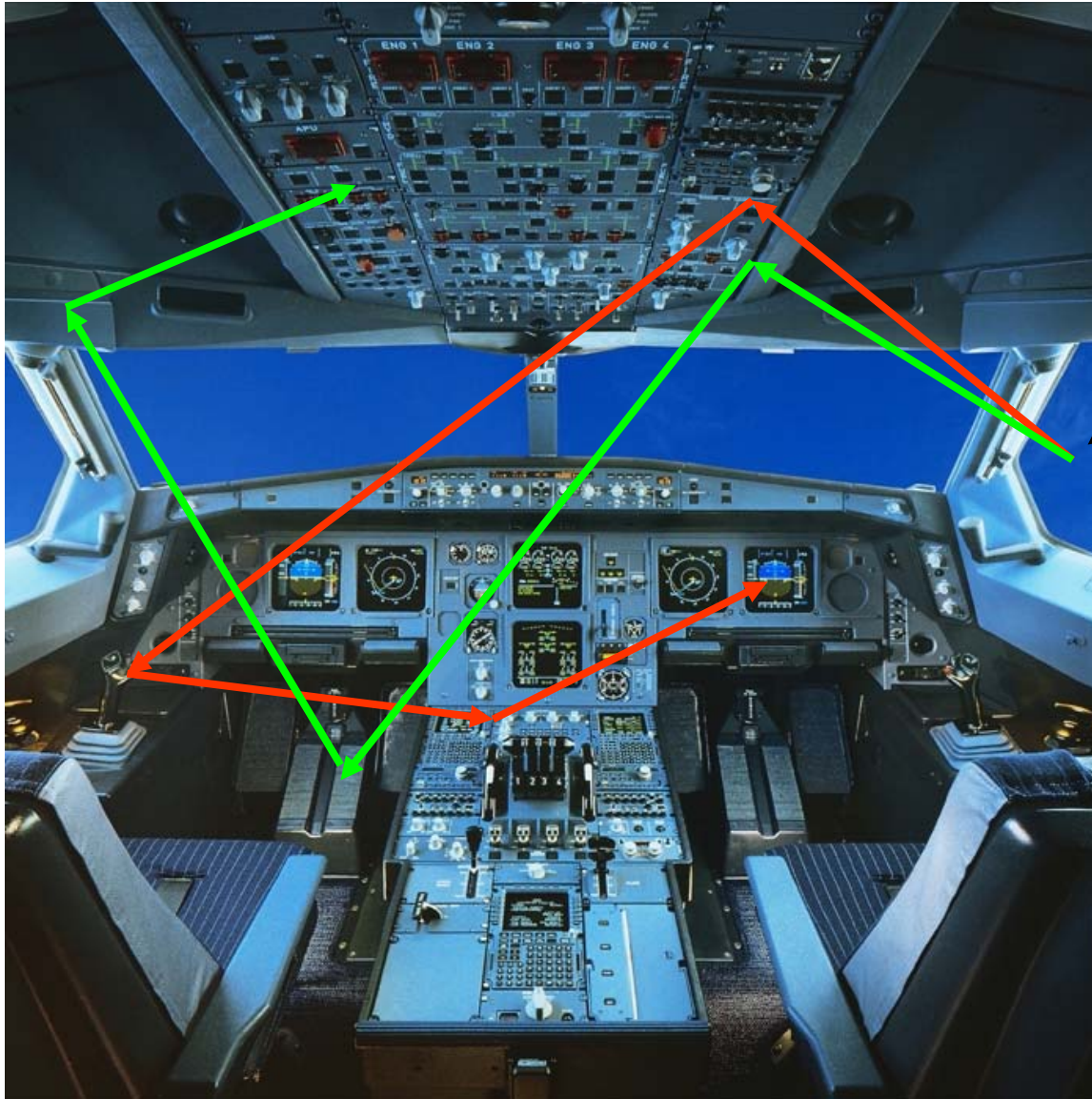
Chaotic Ray Trajectories

Related work: (Field distributions in reverberation chambers, etc.)
R. Holland and R. St. John, *Statistical Electromagnetics* (Taylor and Francis, Philadelphia, 1999).
D. A. Hill *et al.*, IEEE Trans. Electromag. Compat. **36**, 169 (1994).
L. K. Warne *et al.*, IEEE Trans. Antennas Propag. **51**, 978 (2003).
C. Fiachetti and B. Michielsen, Electronics Lett. **39**, 1713 (2003).
and others...

What is Ray Chaos?



The Wave Chaos approach applies to systems that display Ray Chaos

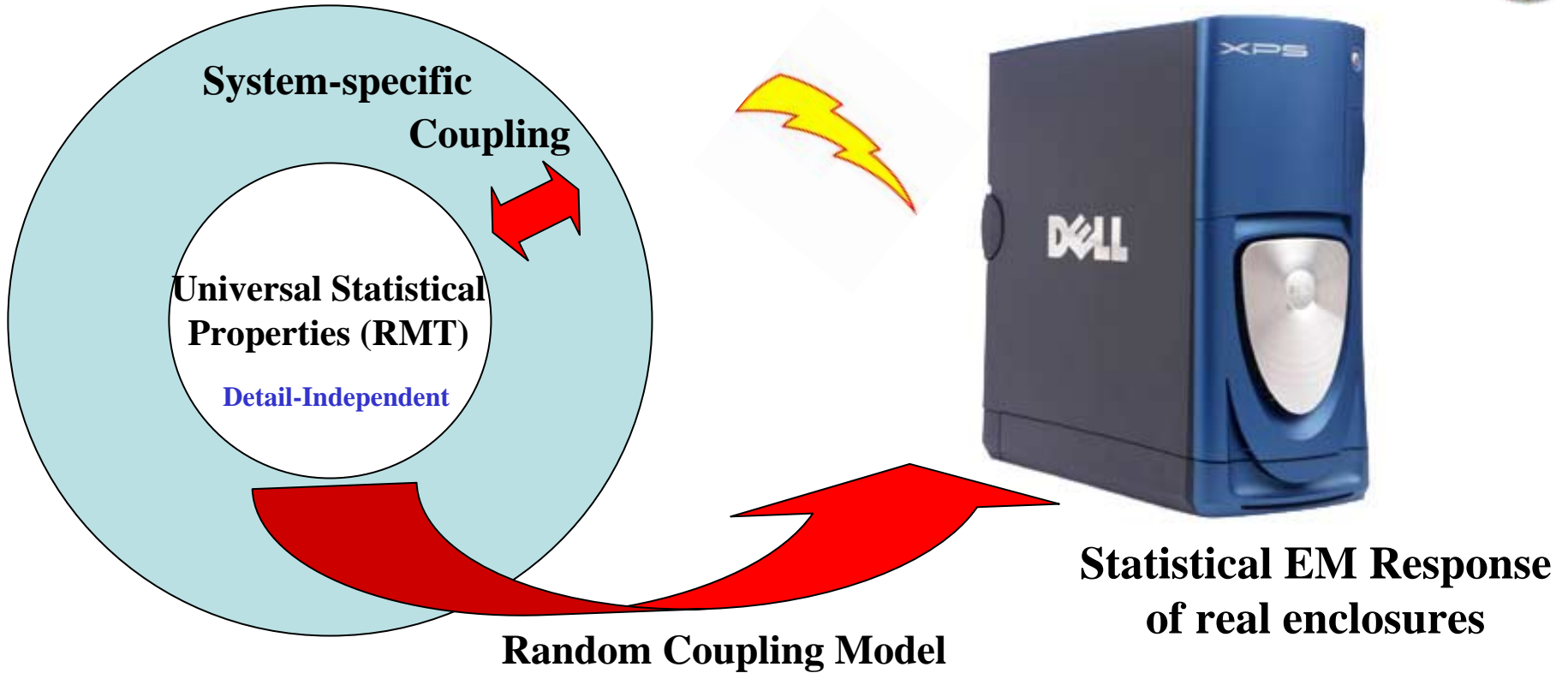


Consider Newtonian ray orbits (3D billiards)

Two incident rays with slightly different initial directions have rapidly diverging trajectories

Practical Implications for Real Life Problems

Bare Minimum Specifications for Induced-Voltage Statistics



What are the bare minimum specifications to accurately predict voltage Statistics?

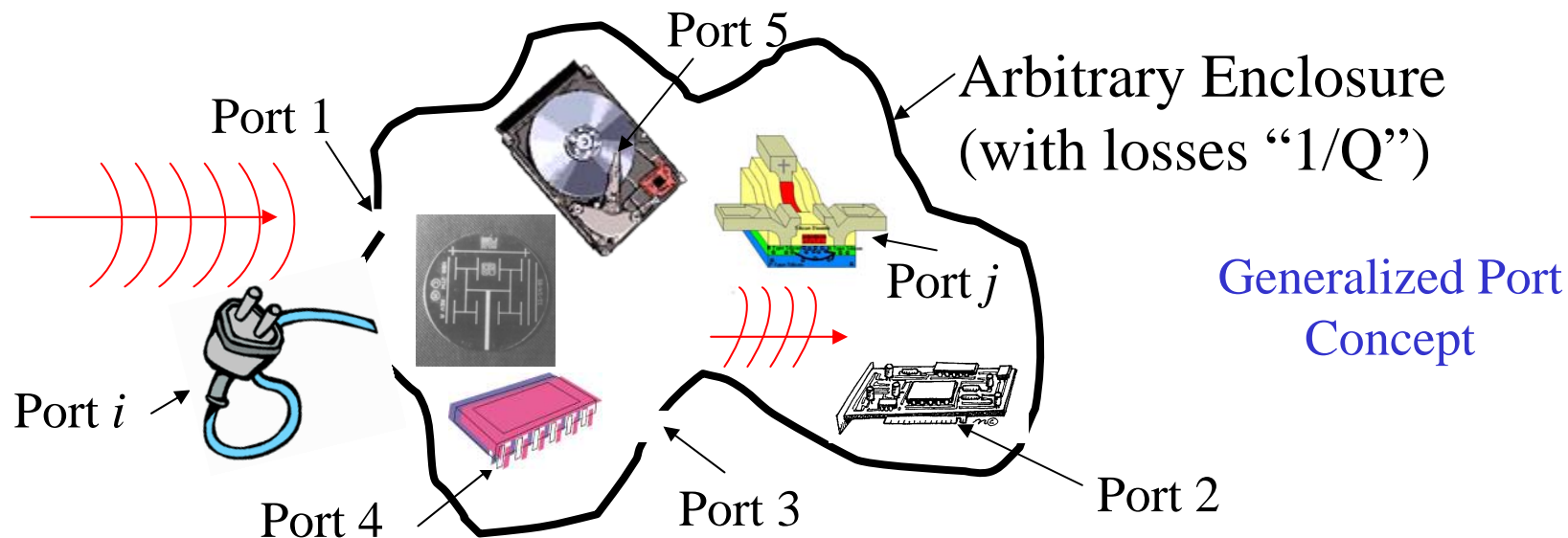
Minimum Information to predict PDF of induced voltages at an internal port:

Frequency, Volume
Losses
Radiation impedance of the ports
Radiated power Wave-form from port 1

$$\alpha = \frac{k^3 V}{2\pi^2 Q}$$

Determine the shape and scales of the induced voltage PDFs

Induced Voltage Distributions for Objects in an Arbitrary Enclosure



Electromagnetics, 26 3 (2006)
Electromagnetics, 26 37 (2006)

Our approach treats all objects of interest as “ports”

Incident rf energy enters the enclosure through one or more ports

The energy reverberates and is absorbed by one or more ports inside the enclosure

Key quantities are the radiation impedances (Z_{Rad}) of the ports



Cavity Impedance has Mean + Fluc Parts

When applied to an ensemble of ray-chaotic cavities, the impedance becomes;

$$Z = \bar{Z} + \tilde{Z} = jX_{Rad} + (\rho + j\xi)R_{Rad}$$

Mean part
Fluctuating part

$\langle \rho \rangle = 1$
 $\langle \xi \rangle = 0$

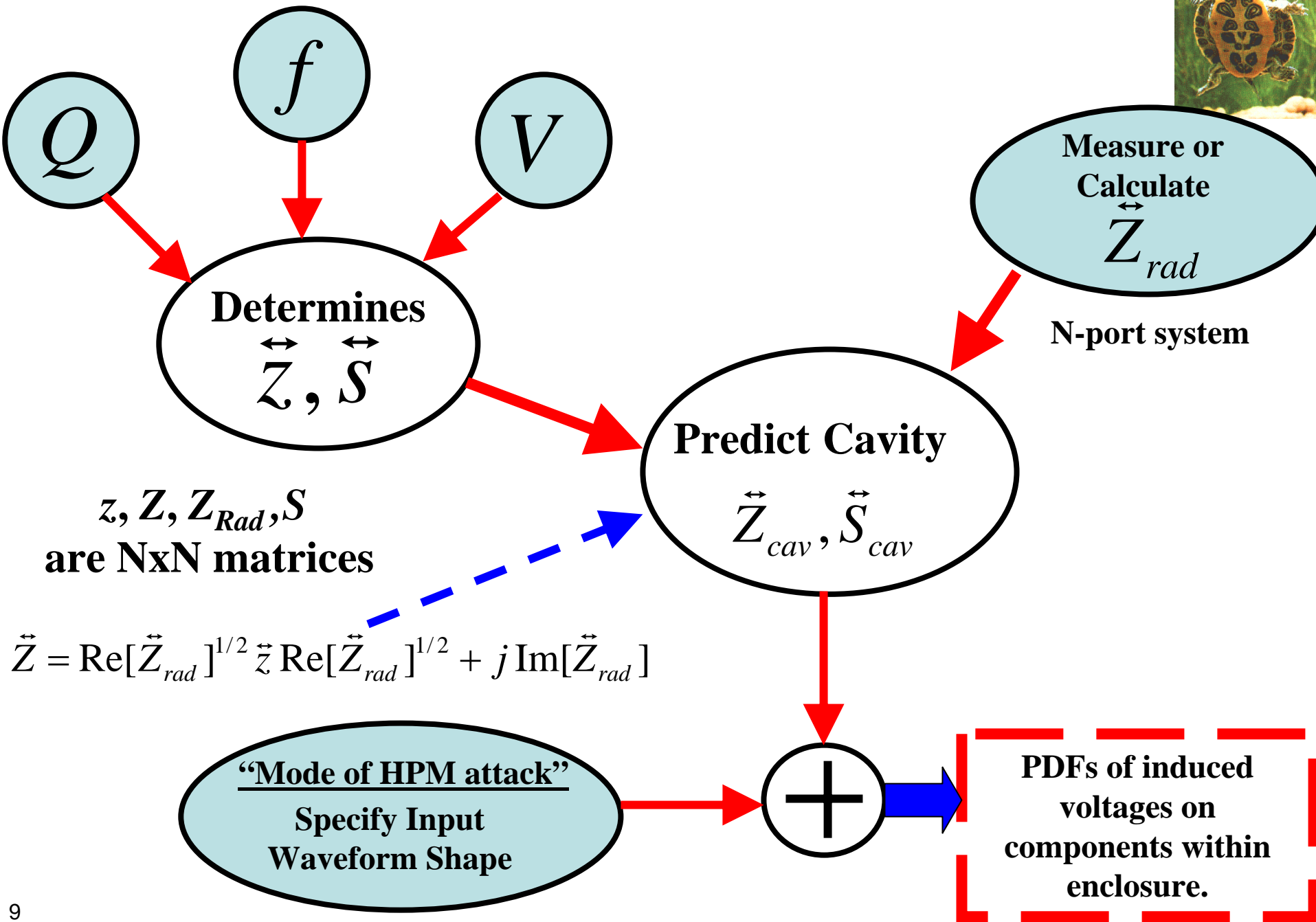
$$z = \rho + j\xi = \frac{Z - jX_{Rad}}{R_{Rad}}$$

Normalized impedance
 “perfect coupled”
 ρ, ξ distributions depend only on loss

Two measurements are required: 1) Z of chaotic system; 2) Z_{Rad}

Loss Parameter: $\frac{k^2}{\Delta k_n^2 Q} \sim \frac{\text{Im}[\omega_0]}{\Delta \omega}$ (sometimes called α)

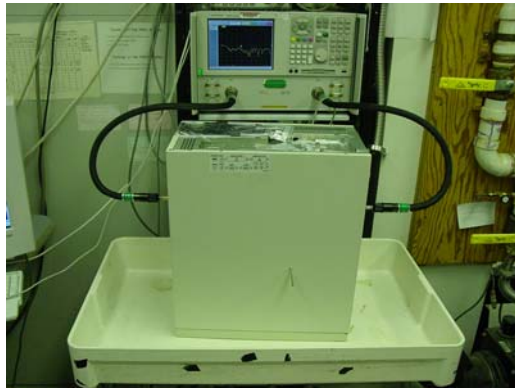
“Terrapin algorithm” for *a priori* prediction of Induced Voltage PDFs



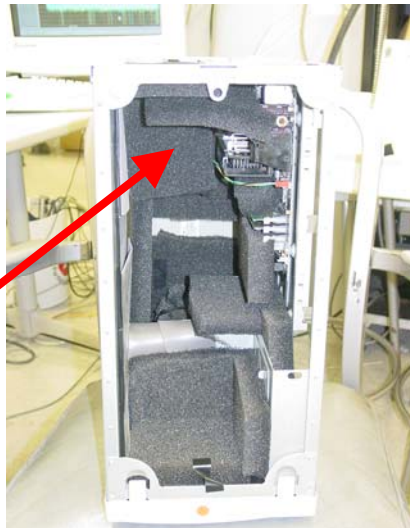
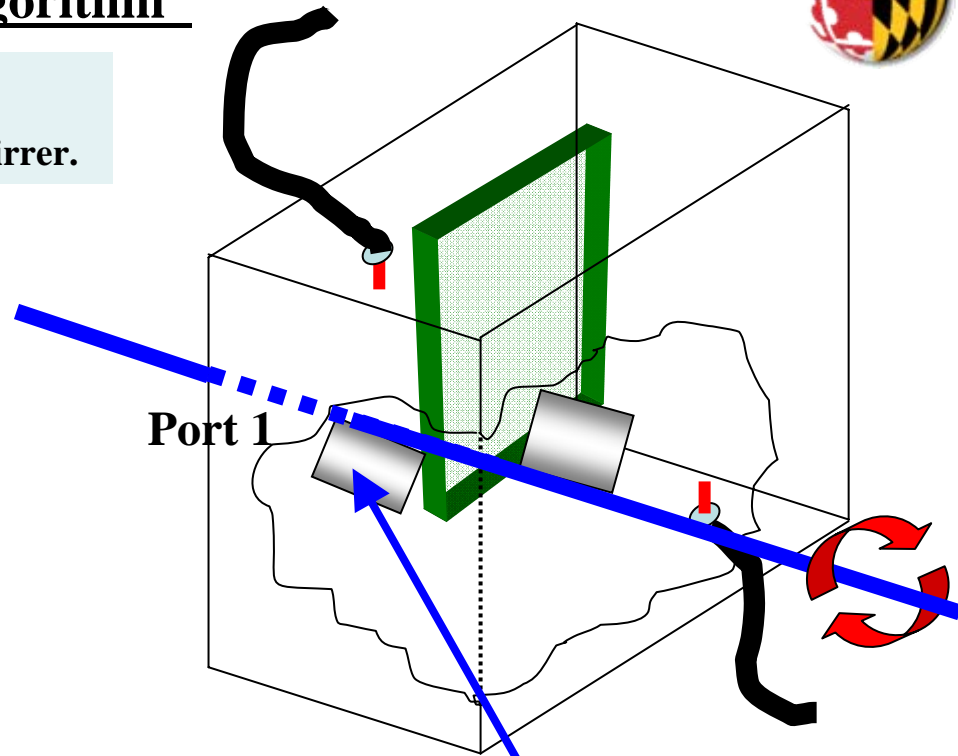
“3D Real-World” Test of the Random Coupling Model and the “Terrapin Algorithm”



- Frequency Range: 2GHz to 20 GHz ($\lambda \ll L$)
- Ensemble Averaging over ~20 positions of the mode-stirrer.



Experimental Setup [Cavity Case]

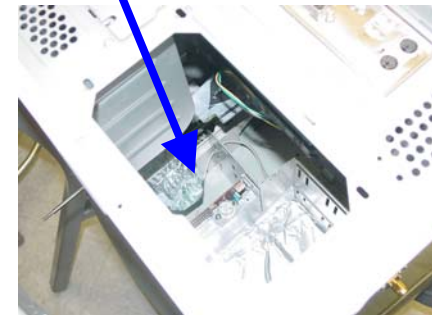
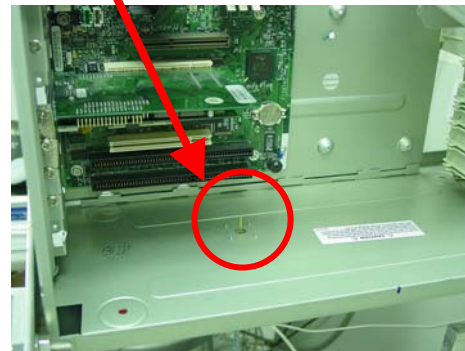


Microwave absorber

Port 2

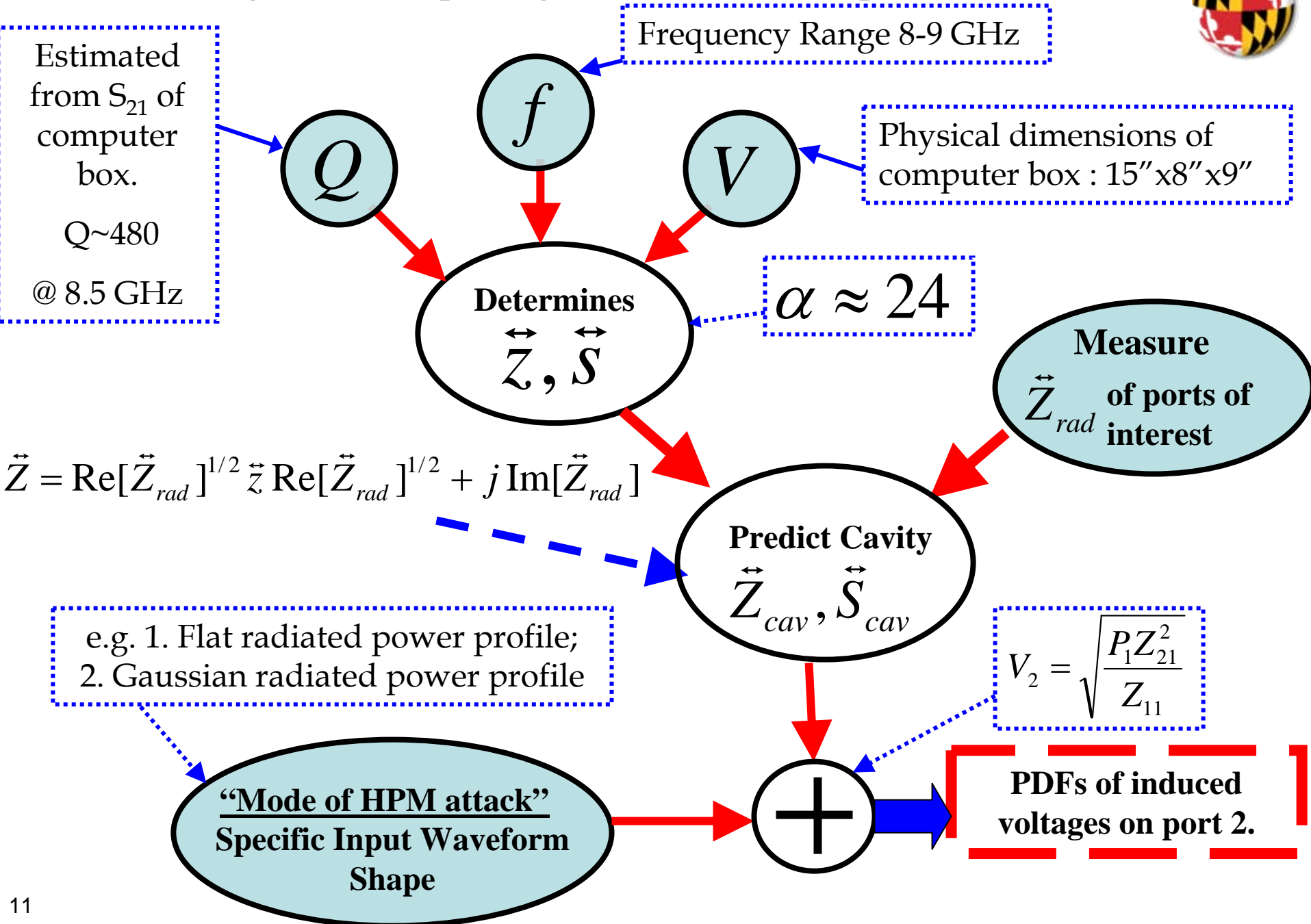
Port 2

Paddle-Wheel Mode-Stirrer



Port Radiation Measurement Setup

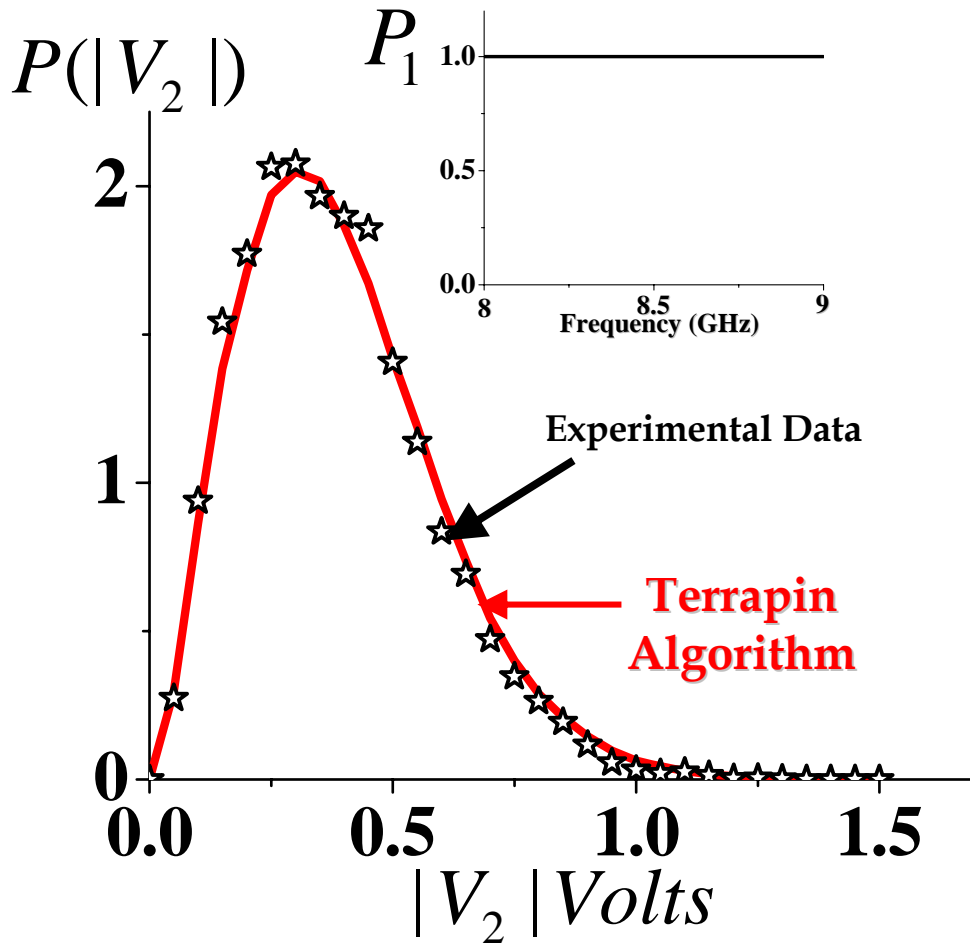
Tutorial: Using the “Terrapin Algorithm” on the computer-box:



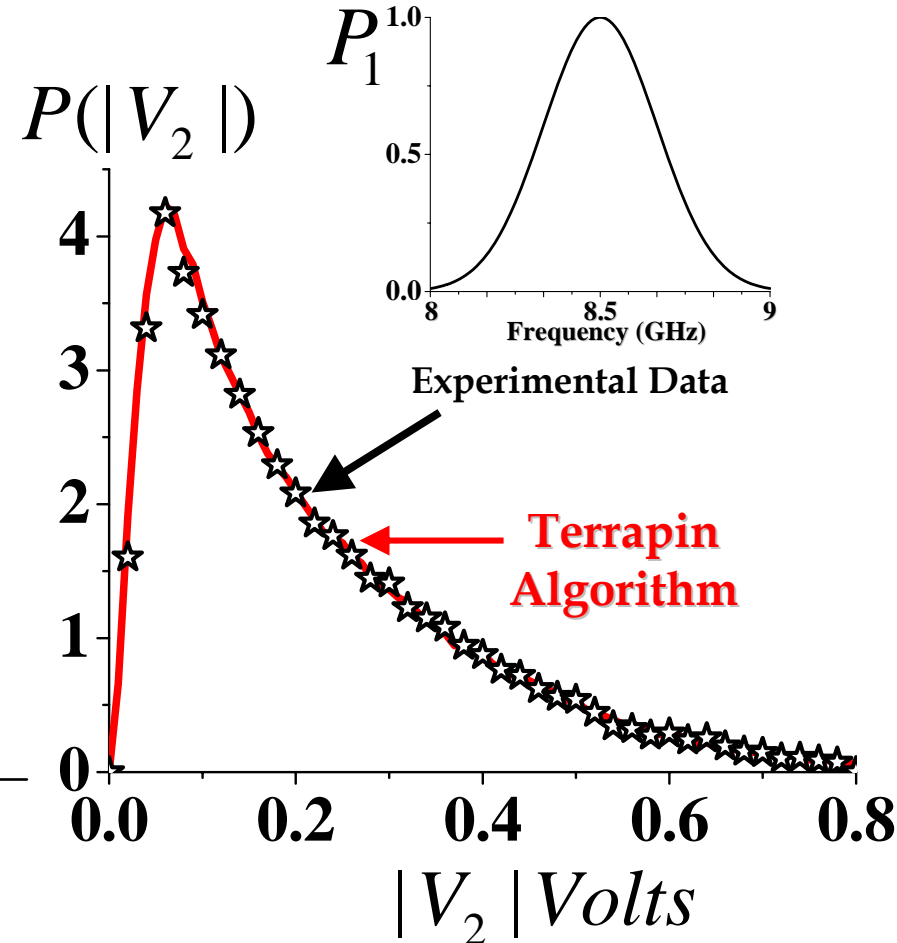


PDF of induced voltages on port 2 of computer-box for different power-spectral densities radiated at Port 1

Flat PSD radiated
from port 1



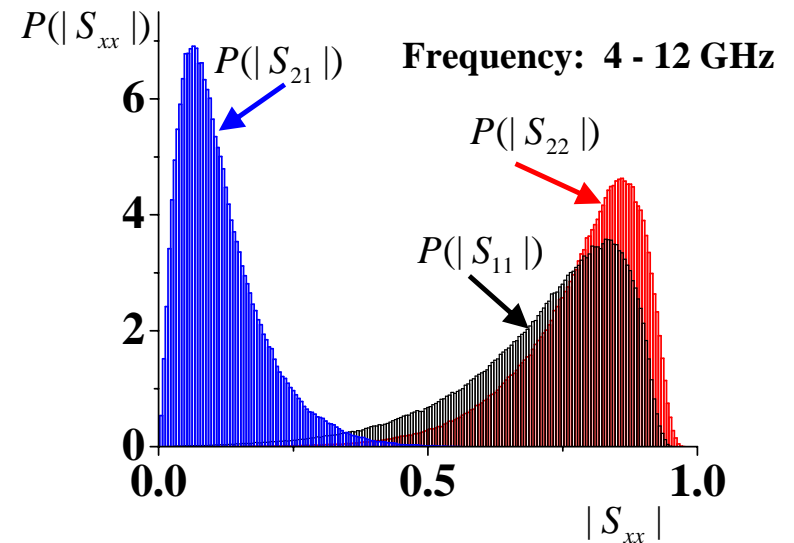
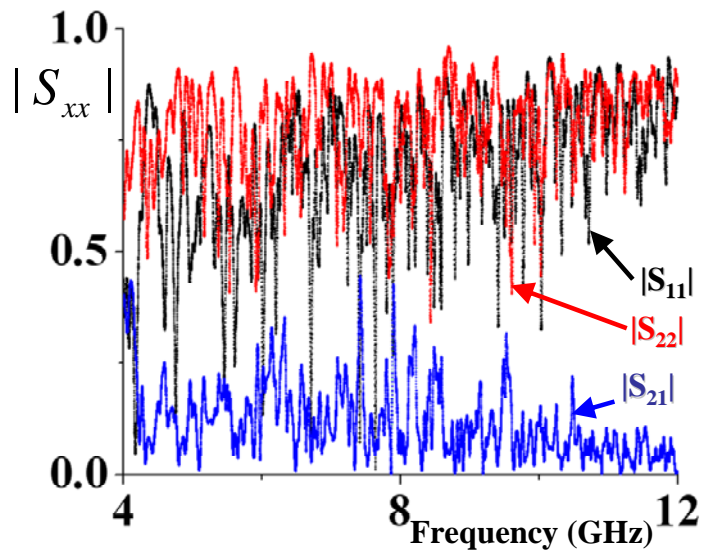
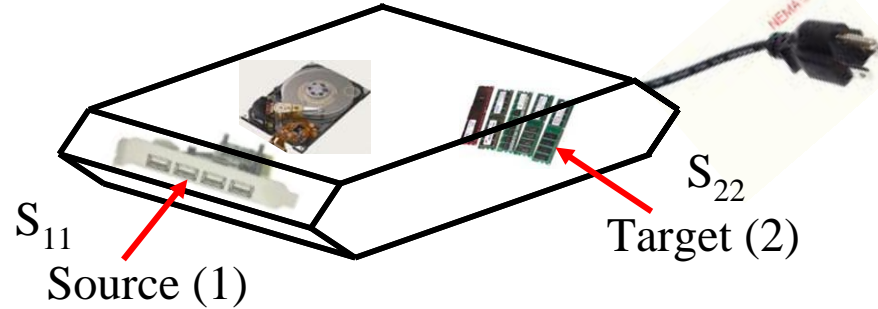
Gaussian-shaped PSD
radiated from port 1



Variance of Voltage and Current Distributions on the Target



Given the variance of S_{11} and S_{22} , we can predict the variance of the induced voltage and current distributions in the target



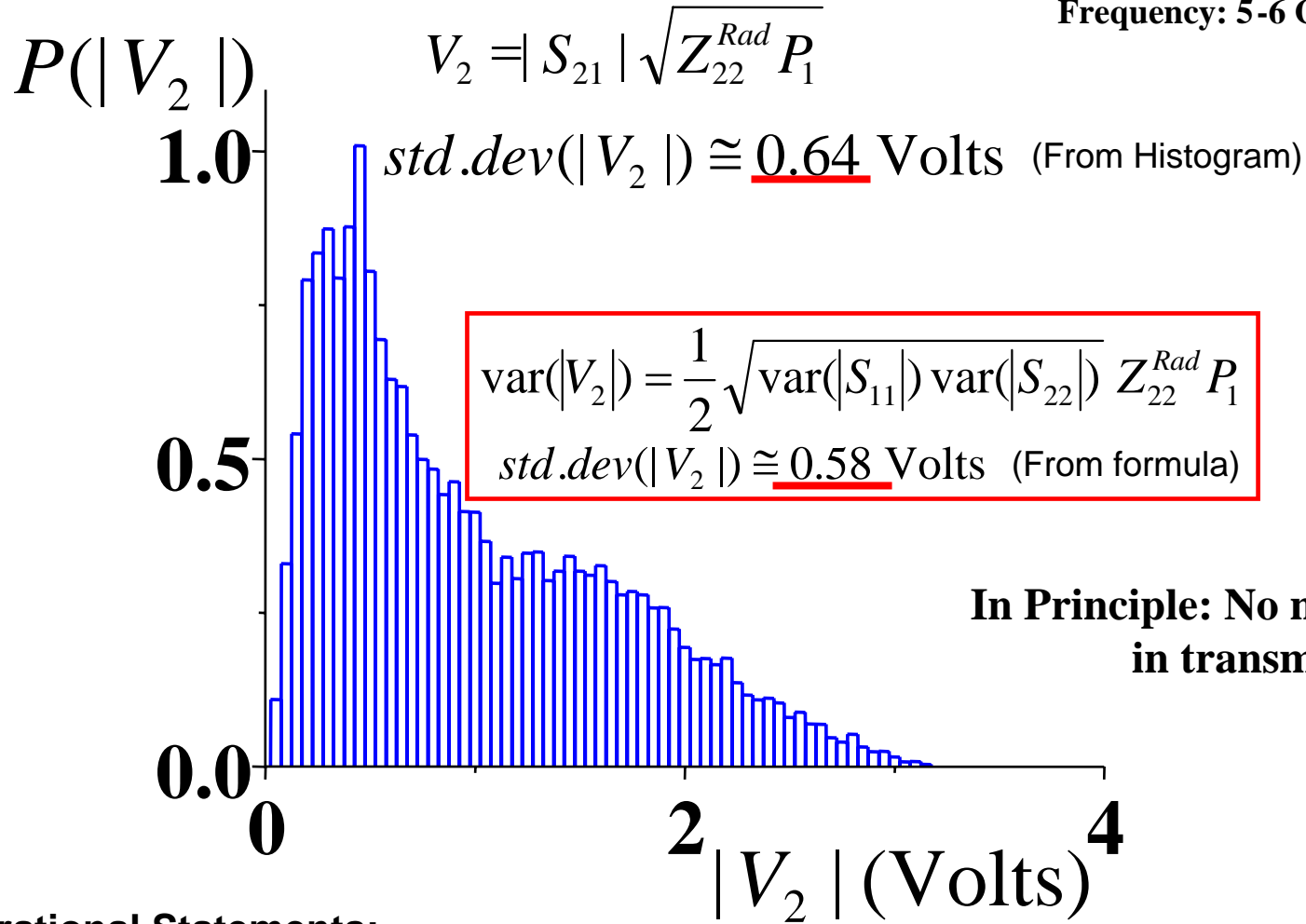
$$\text{Var}(S_{12}) \approx \frac{1}{2} \sqrt{\text{Var}(S_{11})\text{Var}(S_{22})} \quad (\text{ONERA})$$

Or :
$$\text{Var}(Z_{12}) = \frac{1}{2} \sqrt{\text{Var}(Z_{11})\text{Var}(Z_{22})} \quad (\text{Maryland})$$

PDF of Induced Voltages on Port 2 with 1 Watt Radiated by port 1:



Frequency: 5-6 GHz



**In Principle: No need to measure
in transmission!**

Operational Statements:

Measure $Var(Z_{11})$ of the target to quantify its degree of susceptibility to HPM attack

Minimizing $Var(Z_{11})$ of the target is a strategy for minimizing damage from HPM attack

Random Coupling Model Web Site / CD



<http://www.csr.umd.edu/anlage/RCM/index.htm>

Contents:

Introduction to the Random Coupling Model (RCM)

Computer Code (MatLab) <Terrapin RCM Solver v1.0 - by special request>

Generate predictions of induced-voltage PDFs (Speed: ~ 5 minutes)

“Normalize” data to find universal S, Z statistics

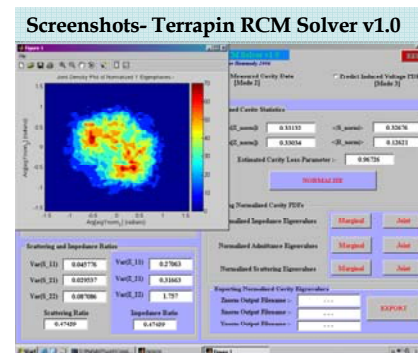
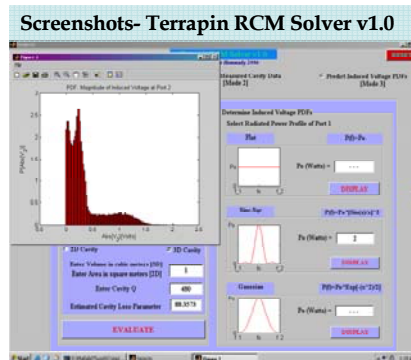
Tutorial on using the code

Example data and calculations

Frequently Asked Questions and Answers about the RCM

Caveats and limitations of the model

All of our publications and selected talks



We encourage others to pick up our model, TEST it, and USE it in your applications

We are happy to help you understand and use the model! (anlage@umd.edu)

Random Coupling Model: CAVEATS



What could possibly go wrong?

You need to predict the outcome of a specific measurement in a specific situation
The RCM provides only statistical predictions

Strong periodic contributions to the ray dynamics (e.g. short periodic orbits from parallel planes)

Can lead to deviations from RCM predictions: Scars, perhaps “Freak Waves”

Solutions: Mixed-dynamics systems heavily studied in quantum chaos

Scar identification: Antonsen, *et al.*, Phys. Rev. E 51, 111 (1995)

New method to identify and account for system-specific short periodic orbits

When do you NOT want to use this model?

Enclosure $Q \sim 1$. No reverberation, no chaos, very lossy

Enclosure size NOT much larger than wavelength λ . Direct numerical solution not sensitive to details

Rule of thumb: enclosure dimension $>$ about 5-10 λ

Remember: Dielectrics inside the enclosure increase its effective size

Our Vision for the Future... Extensions, Improvements, etc.

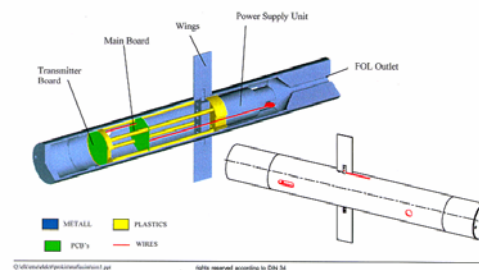


Random Coupling Model shows very promising signs... But still in its infancy.

Further Experimental Validation of the RCM

- **GENEC device**
- **Mode-Stirred Chamber tests**
- **Other antenna configurations (apertures, bundle of cables, etc.)**
- **Non-Reciprocal Media as a way to mitigate EM “Hot Spots”**

GENEC Hardware



Mode-stirred chamber at ONERA

Transfer the Model and it's predictive capabilities to the END User:

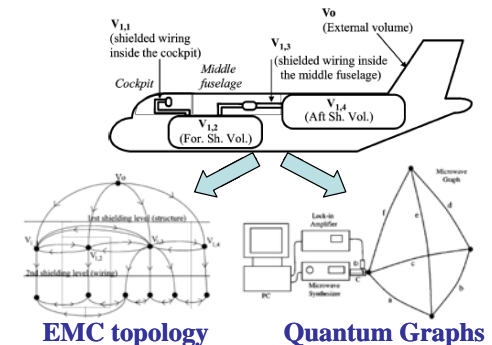
- **Created a code (Terrapin RCM Solver 1.0) to make predictions of induced voltages**
- **Educate the User in the strategy and execution of predictions**

Extend RCM to Pulsed Time-Domain Measurements:

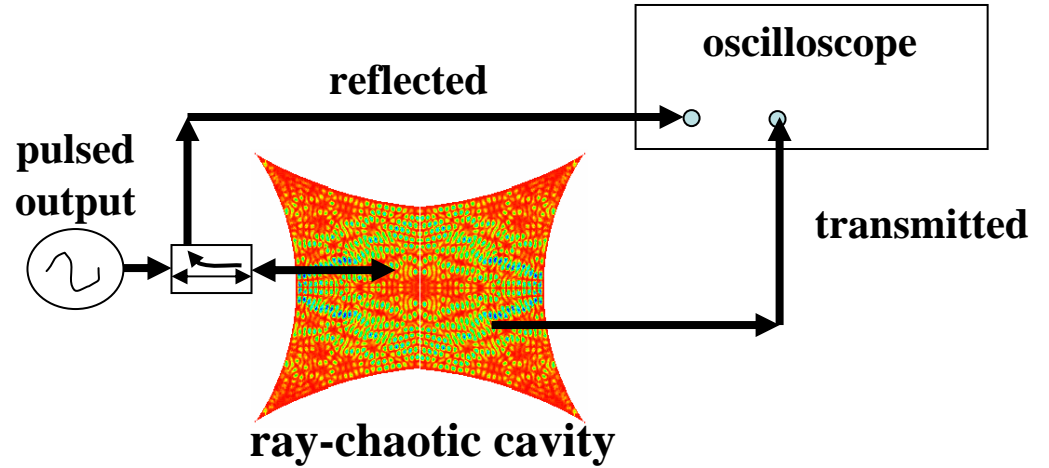
- **Compelling Theoretical Work – Hart, Antonsen, Ott**
 - **Time-Reversed Attack (see Ed Ott's talk tomorrow!)**
- **Experimental work is encouraging**

Connect RCM to the EM Topology Approach:

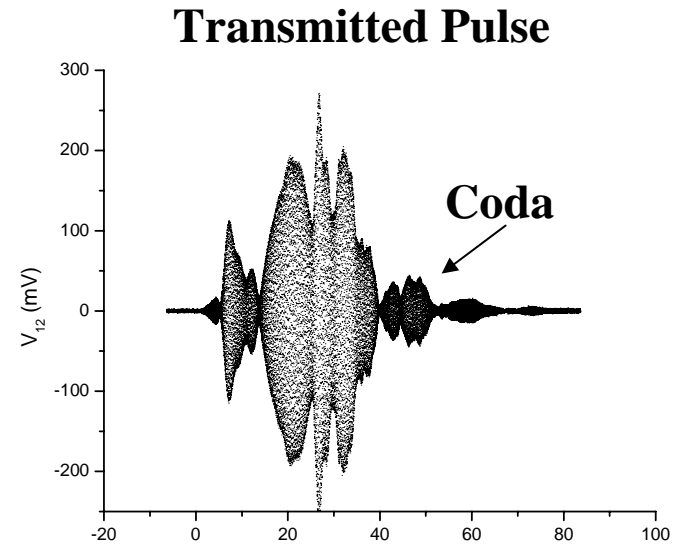
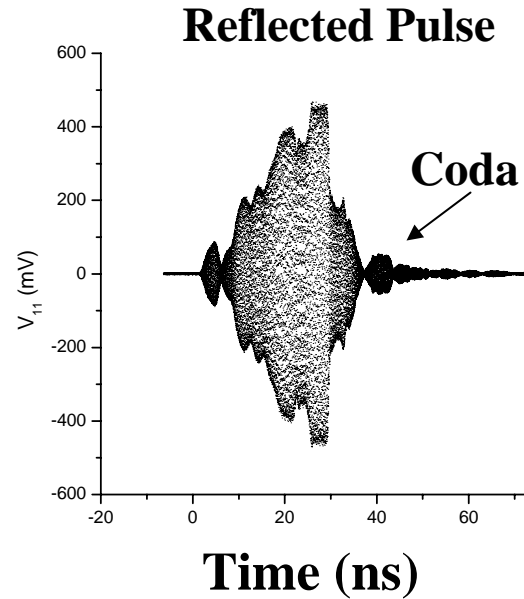
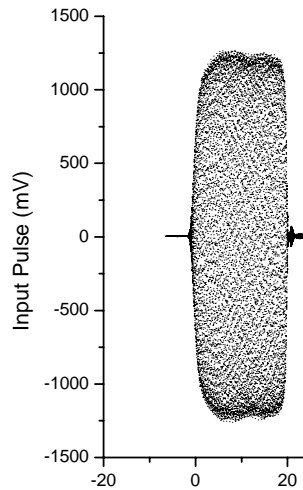
- **Quantum graphs and chaos on networks**



Time Domain Results



Incident Pulse
10 ns long @ 7.68 GHz



Conclusions



We have developed a Random Coupling Model (based on RMT) to make statistical predictions of induced voltages in complicated enclosures

Experimental tests of many basic 1 port and 2-port predictions have confirmed that the approach is correct in 2D and 3D.

Frequency, Volume } $\frac{k^2}{\Delta k^2 Q}$ } Determine the Z, S PDFs
Losses }
Radiation impedance of the ports }

Clear strategies to engineer the PDFs to suit one's purpose

We encourage everyone to try it!

Random Coupling Model User's Guide + Code:

<http://www.csr.umd.edu/anlage/RCM/index.htm>

anlage@umd.edu